



# STF19NM50N STP19NM50N, STW19NM50N

N-channel 500 V, 0.2  $\Omega$ , 14 A MDmesh™ II Power MOSFET  
in TO-220FP, TO-220 and TO-247

## Features

| Type                                   | V <sub>DSS</sub> @<br>T <sub>Jmax</sub> | R <sub>DS(on)</sub><br>max | I <sub>D</sub> |
|--|---|----------------------------|----------------|
| STF19NM50N<br>STP19NM50N<br>STW19NM50N | 550 V                                   | < 0.25 $\Omega$            | 14 A           |

- 100% avalanche tested
- Low input capacitances and gate charge
- Low gate input resistance

## Application

- Switching applications

## Description

This second generation of MDmesh™ technology, applies the benefits of the multiple drain process to STMicroelectronics' well-known PowerMESH™ horizontal layout structure. The resulting product offers improved on-resistance, low gate charge, high dv/dt capability and excellent avalanche characteristics.

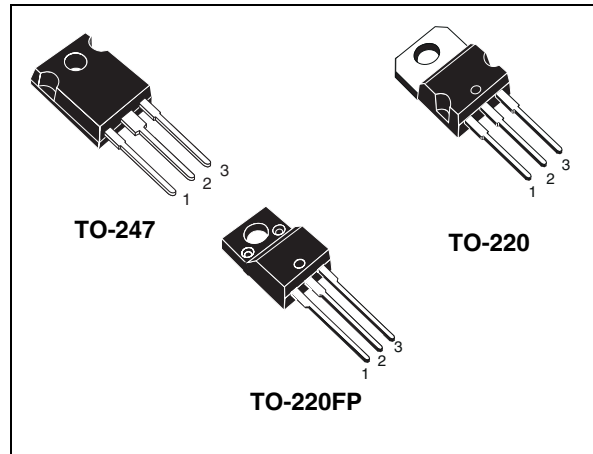


Figure 1. Internal schematic diagram

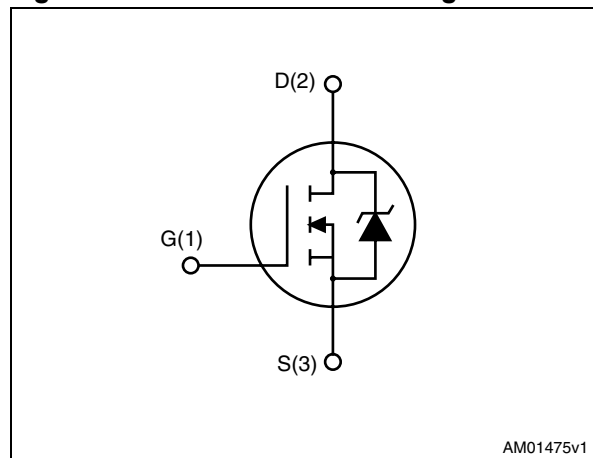


Table 1. Device summary

| Order codes | Marking | Package  | Packaging |
|-------------|---------|----------|-----------|
| STF19NM50N  | 19NM50N | TO-220FP | Tube      |
| STP19NM50N  |         | TO-220   |           |
| STW19NM50N  |         | TO-247   |           |

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# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

| Symbol         | Parameter   | Value       |        |                   | Unit             |
|----------------|---|-------------|--------|-------------------|------------------|
|                |   | TO-220      | TO-247 | TO-220FP          |                  |
| $V_{DS}$       | Drain-source voltage ( $V_{GS} = 0$ )   | 500         |        |                   | V                |
| $V_{GS}$       | Gate-source voltage   | $\pm 25$    |        |                   | V                |
| $I_D$          | Drain current (continuous) at $T_C = 25\text{ }^\circ\text{C}$  | 14          |        | 14 <sup>(1)</sup> | A                |
| $I_D$          | Drain current (continuous) at $T_C = 100\text{ }^\circ\text{C}$   | 9           |        | 9 <sup>(1)</sup>  | A                |
| $I_{DM}^{(2)}$ | Drain current (pulsed)  | 56          |        | 56 <sup>(1)</sup> | A                |
| $P_{TOT}$      | Total dissipation at $T_C = 25\text{ }^\circ\text{C}$   | 110         |        | 30                | W                |
| $dv/dt^{(3)}$  | Peak diode recovery voltage slope   | 15          |        |                   | V/ns             |
| $V_{ISO}$      | Insulation withstand voltage (RMS) from all three leads to external heat sink ( $t = 1\text{ s}$ ; $T_C = 25\text{ }^\circ\text{C}$ ) | 2500        |        |                   | V                |
| $T_{stg}$      | Storage temperature   | - 55 to 150 |        |                   | $^\circ\text{C}$ |
| $T_j$          | Max. operating junction temperature   | 150         |        |                   | $^\circ\text{C}$ |

- Limited only by maximum temperature allowed
- Pulse width limited by safe operating area
- $I_{SD} \leq 14\text{ A}$ ,  $di/dt \leq 400\text{ A}/\mu\text{s}$ ,  $V_{Peak} < V_{(BR)DSS}$

**Table 3. Thermal data**

| Symbol         | Parameter                                      | Value  |        |          | Unit                      |
|----------------|--|--------|--------|----------|---------------------------|
|                |  | TO-220 | TO-247 | TO-220FP |                           |
| $R_{thj-case}$ | Thermal resistance junction-case max           | 1.14   |        | 4.17     | $^\circ\text{C}/\text{W}$ |
| $R_{thj-amb}$  | Thermal resistance junction-ambient max        | 62.5   | 50     | 62.5     | $^\circ\text{C}/\text{W}$ |
| $T_l$          | Maximum lead temperature for soldering purpose | 300    |        |          | $^\circ\text{C}$          |

**Table 4. Avalanche characteristics**

| Symbol   | Parameter  | Value | Unit |
|----------|--|-------|------|
| $I_{AR}$ | Avalanche current, repetitive or not-repetitive (pulse width limited by $T_j$ max)                                   | 7     | A    |
| $E_{AS}$ | Single pulse avalanche energy (starting $T_j = 25\text{ }^\circ\text{C}$ , $I_D = I_{AR}$ , $V_{DD} = 50\text{ V}$ ) | 208   | mJ   |

## 2 Electrical characteristics

( $T_C = 25\text{ °C}$  unless otherwise specified)

**Table 5. On /off states**

| Symbol        | Parameter  | Test conditions  | Min. | Typ. | Max.    | Unit                           |
|---------------|--|--|------|------|---------|--------------------------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage                   | $I_D = 1\text{ mA}$ , $V_{GS} = 0$   | 500  |      |         | V                              |
| $I_{DSS}$     | Zero gate voltage drain current ( $V_{GS} = 0$ ) | $V_{DS} = \text{Max rating}$<br>$V_{DS} = \text{Max rating}$ , $T_C = 125\text{ °C}$ |      |      | 1<br>10 | $\mu\text{A}$<br>$\mu\text{A}$ |
| $I_{GSS}$     | Gate-body leakage current ( $V_{DS} = 0$ )       | $V_{GS} = \pm 25\text{ V}$   |      |      | 10      | $\mu\text{A}$                  |
| $V_{GS(th)}$  | Gate threshold voltage                           | $V_{DS} = V_{GS}$ , $I_D = 250\text{ }\mu\text{A}$                                   | 2    | 3    | 4       | V                              |
| $R_{DS(on)}$  | Static drain-source on resistance                | $V_{GS} = 10\text{ V}$ , $I_D = 7\text{ A}$  |      | 0.2  | 0.25    | $\Omega$                       |

**Table 6. Dynamic**

| Symbol            | Parameter                             | Test conditions   | Min. | Typ. | Max. | Unit     |
|-------------------|---------------------------------------|---|------|------|------|----------|
| $C_{iss}$         | Input capacitance                     | $V_{DS} = 50\text{ V}$ , $f = 1\text{ MHz}$ ,<br>$V_{GS} = 0$   | -    | 1000 | -    | pF       |
| $C_{oss}$         | Output capacitance                    |   |      | 72   |      | pF       |
| $C_{rss}$         | Reverse transfer capacitance          |   |      | 3    |      | pF       |
| $C_{o(tr)}^{(1)}$ | Equivalent capacitance time related   | $V_{DS} = 0\text{ to }400\text{ V}$ , $V_{GS} = 0$  | -    | 104  | -    | pF       |
| $C_{o(er)}^{(2)}$ | Equivalent capacitance energy related |   |      | 51   |      | pF       |
| $R_G$             | Intrinsic gate resistance             | $f = 1\text{ MHz}$ open drain   | -    | 4.4  | -    | $\Omega$ |
| $Q_g$             | Total gate charge                     | $V_{DD} = 400\text{ V}$ , $I_D = 14\text{ A}$ ,<br>$V_{GS} = 10\text{ V}$<br>(see <a href="#">Figure 19</a> ) | -    | 34   | -    | nC       |
| $Q_{gs}$          | Gate-source charge                    |   |      | 5    |      | nC       |
| $Q_{gd}$          | Gate-drain charge                     |   |      | 18   |      | nC       |

1. Time related is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$
2. Energy related is defined as a constant equivalent capacitance giving the same stored energy as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$

Table 7. Switching times

| Symbol       | Parameter           | Test conditions  | Min. | Typ. | Max | Unit |
|--------------|---------------------|--|------|------|-----|------|
| $t_{d(on)}$  | Turn-on delay time  | $V_{DD} = 250\text{ V}$ , $I_D = 7\text{ A}$ ,<br>$R_G = 4.7\ \Omega$ , $V_{GS} = 10\text{ V}$<br>(see <a href="#">Figure 20</a> ) | -    | 12   | -   | ns   |
| $t_r$        | Rise time           |  |      | 16   |     | ns   |
| $t_{d(off)}$ | Turn-off-delay time |  |      | 61   |     | ns   |
| $t_f$        | Fall time           |  |      | 17   |     | ns   |

Table 8. Source drain diode

| Symbol          | Parameter                     | Test conditions   | Min. | Typ. | Max. | Unit |
|-----------------|-------------------------------|---|------|------|------|------|
| $I_{SD}$        | Source-drain current          |   | -    |      | 14   | A    |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) |   |      |      | 56   | A    |
| $V_{SD}^{(2)}$  | Forward on voltage            | $I_{SD} = 14\text{ A}$ , $V_{GS} = 0$   | -    |      | 1.5  | V    |
| $t_{rr}$        | Reverse recovery time         | $I_{SD} = 14\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$<br>$V_{DD} = 60\text{ V}$ (see <a href="#">Figure 23</a> )  | -    | 296  |      | ns   |
| $Q_{rr}$        | Reverse recovery charge       |   |      | 3.5  |      | nC   |
| $I_{RRM}$       | Reverse recovery current      |   |      | 23   |      | A    |
| $t_{rr}$        | Reverse recovery time         | $I_{SD} = 14\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$<br>$V_{DD} = 60\text{ V}$ , $T_J = 150\text{ }^\circ\text{C}$<br>(see <a href="#">Figure 23</a> ) | -    | 346  |      | ns   |
| $Q_{rr}$        | Reverse recovery charge       |   |      | 4    |      | nC   |
| $I_{RRM}$       | Reverse recovery current      |   |      | 24   |      | A    |

1. Pulse width limited by safe operating area
2. Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

## 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area for TO-220

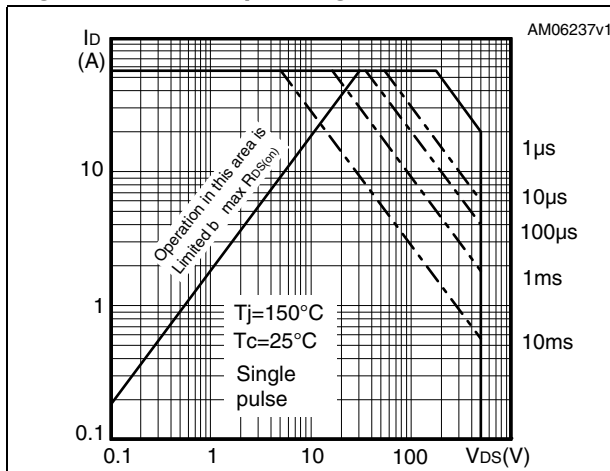


Figure 3. Thermal impedance for TO-220

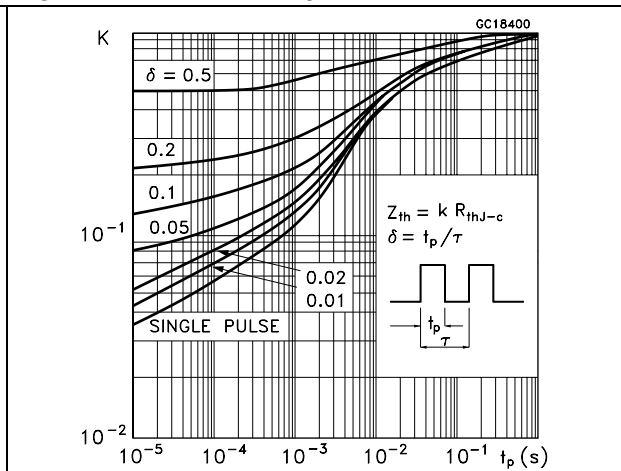


Figure 4. Safe operating area for TO-220FP

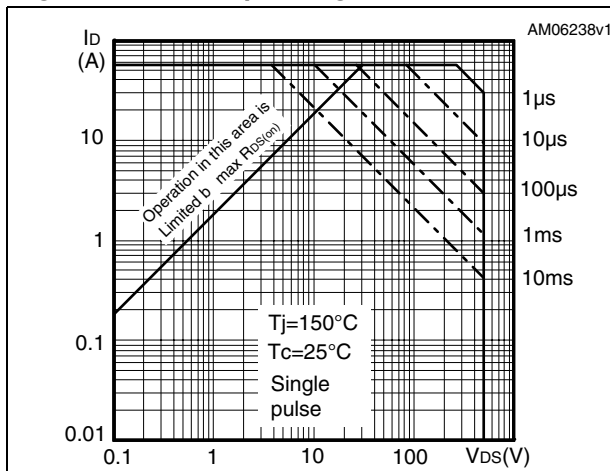


Figure 5. Thermal impedance for TO-220FP

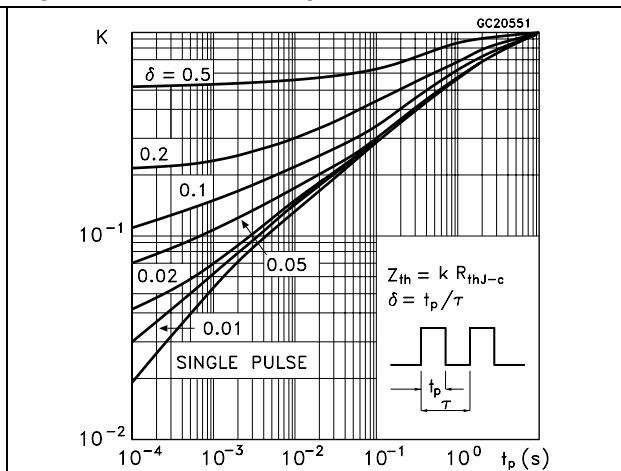


Figure 6. Safe operating area for TO-247

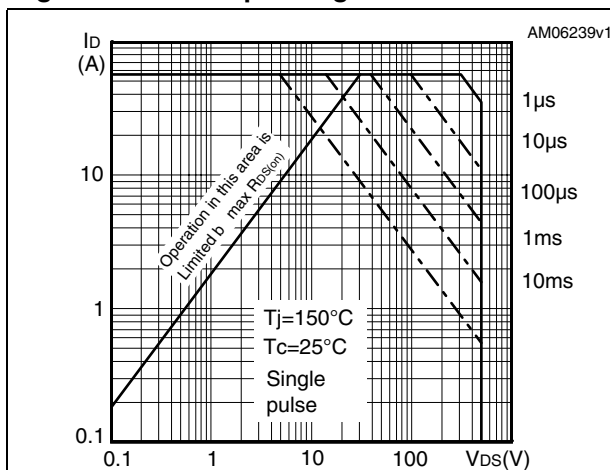


Figure 7. Thermal impedance for TO-247

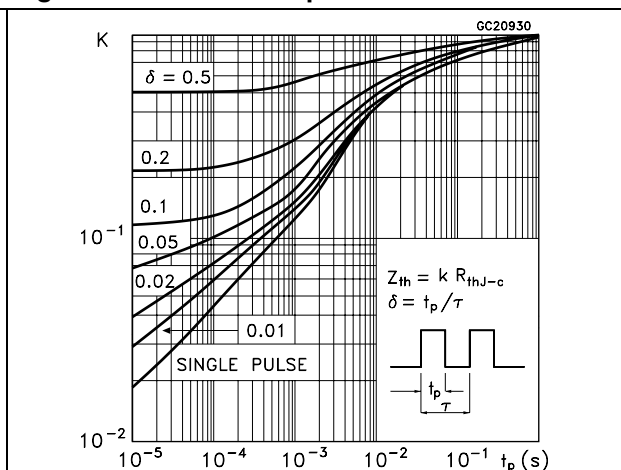


Figure 8. Output characteristics

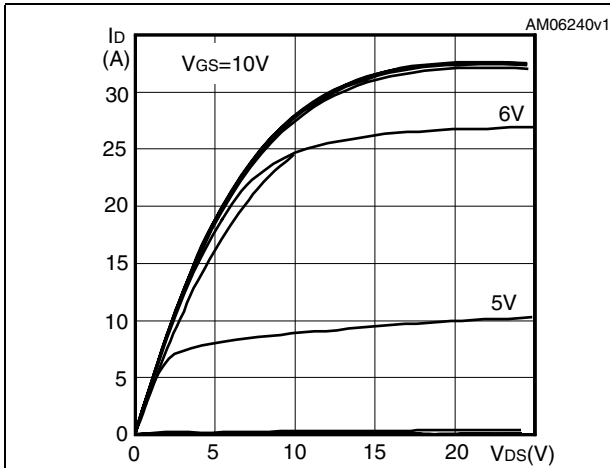


Figure 9. Transfer characteristics

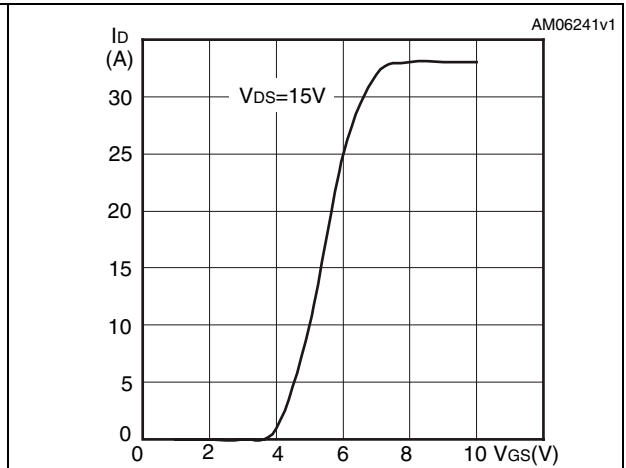


Figure 10. Gate charge vs gate-source voltage Figure 11. Static drain-source on resistance

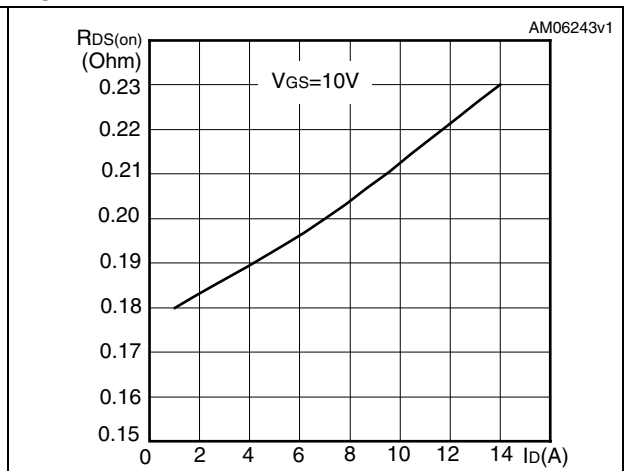
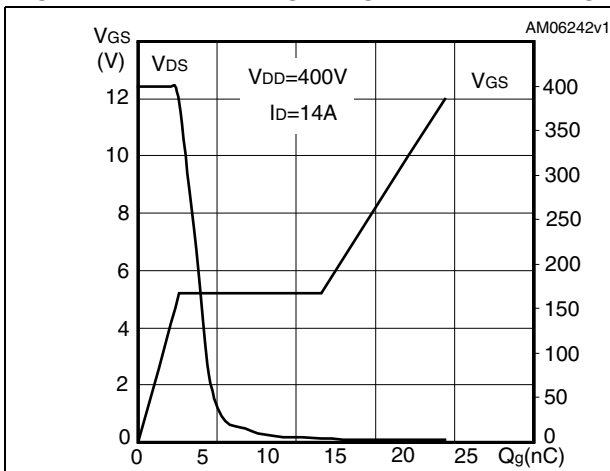


Figure 12. Capacitance variations

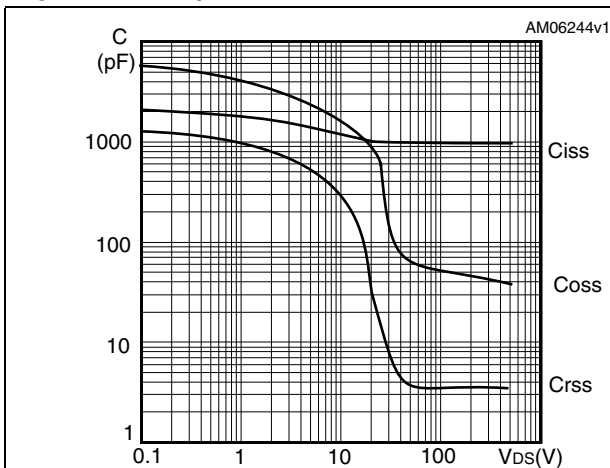


Figure 13. Output capacitance stored energy

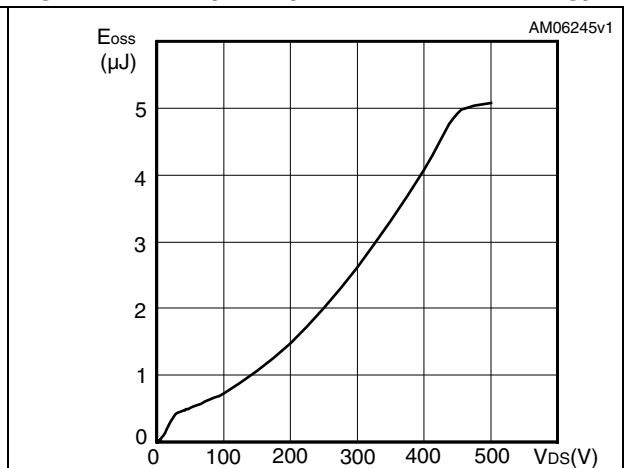


Figure 14. Normalized gate threshold voltage vs temperature

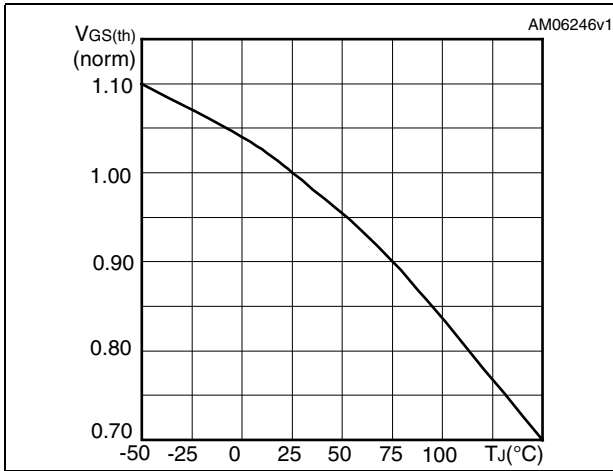


Figure 15. Normalized on resistance vs temperature

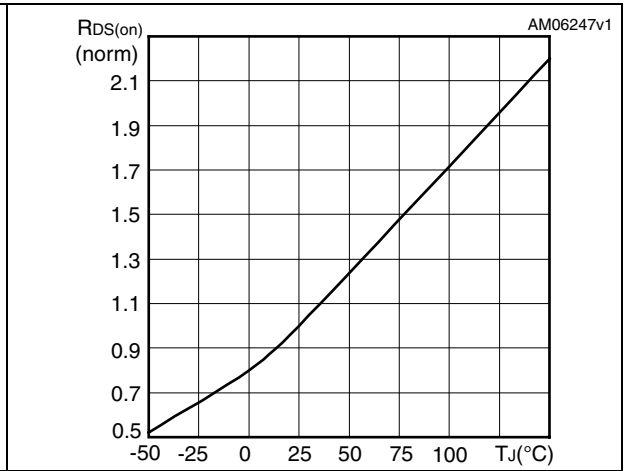


Figure 16. Source-drain diode forward characteristics

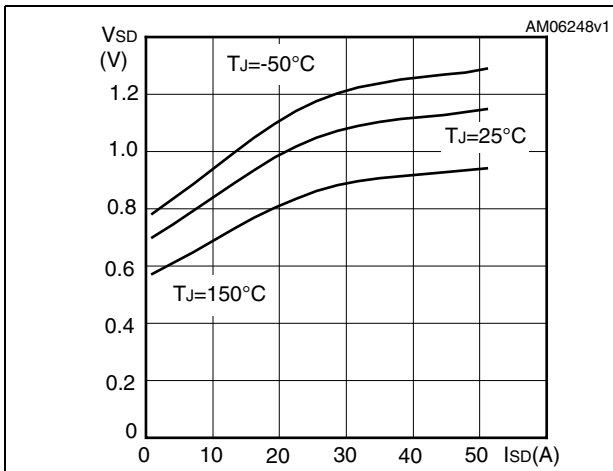
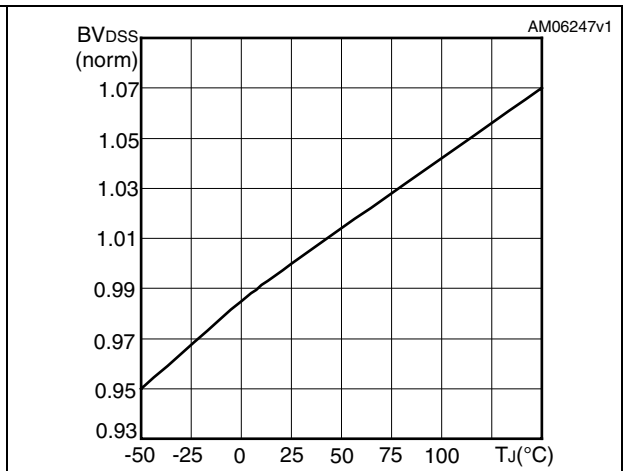
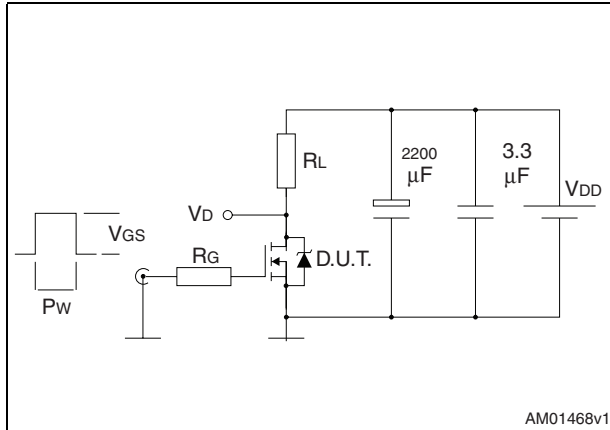


Figure 17. Normalized B<sub>V</sub>DSS vs temperature



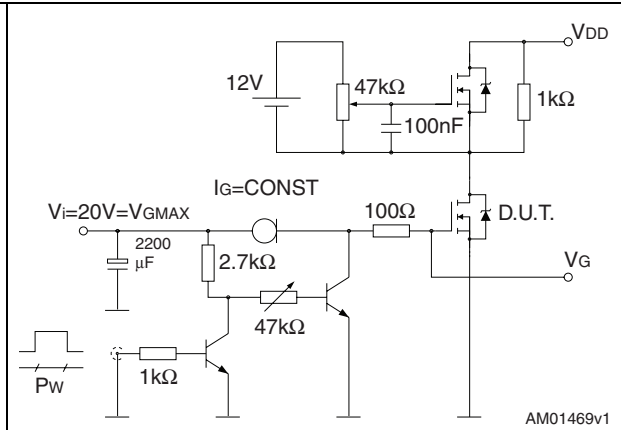
### 3 Test circuits

**Figure 18. Switching times test circuit for resistive load**



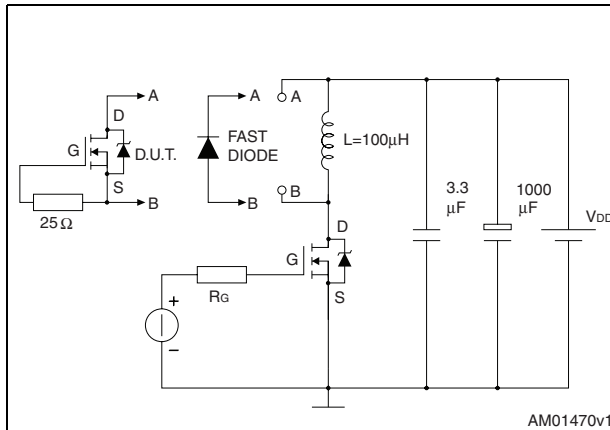
AM01468v1

**Figure 19. Gate charge test circuit**



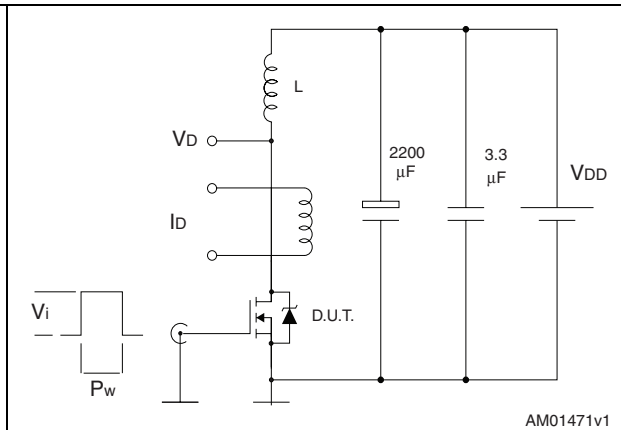
AM01469v1

**Figure 20. Test circuit for inductive load switching and diode recovery times**



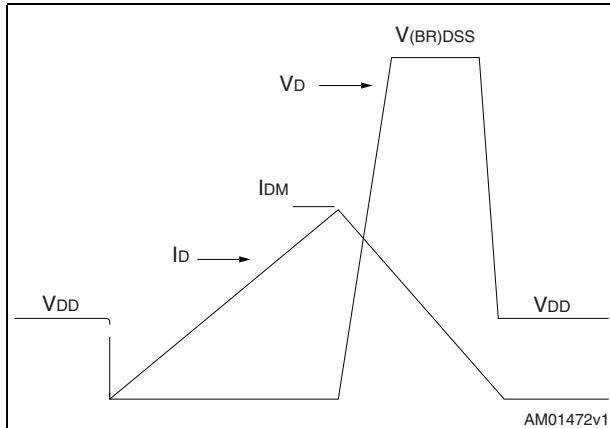
AM01470v1

**Figure 21. Unclamped inductive load test circuit**



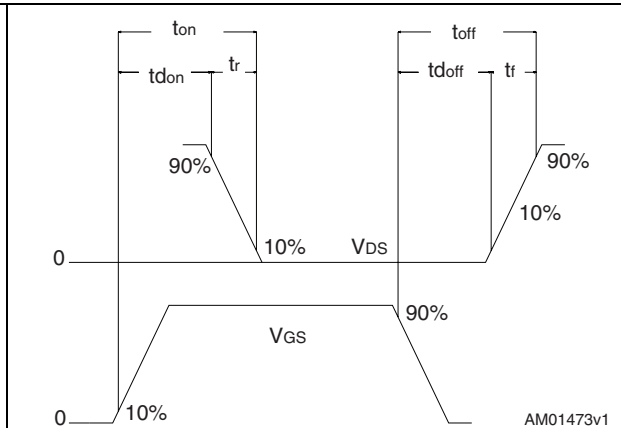
AM01471v1

**Figure 22. Unclamped inductive waveform**



AM01472v1

**Figure 23. Switching time waveform**



AM01473v1

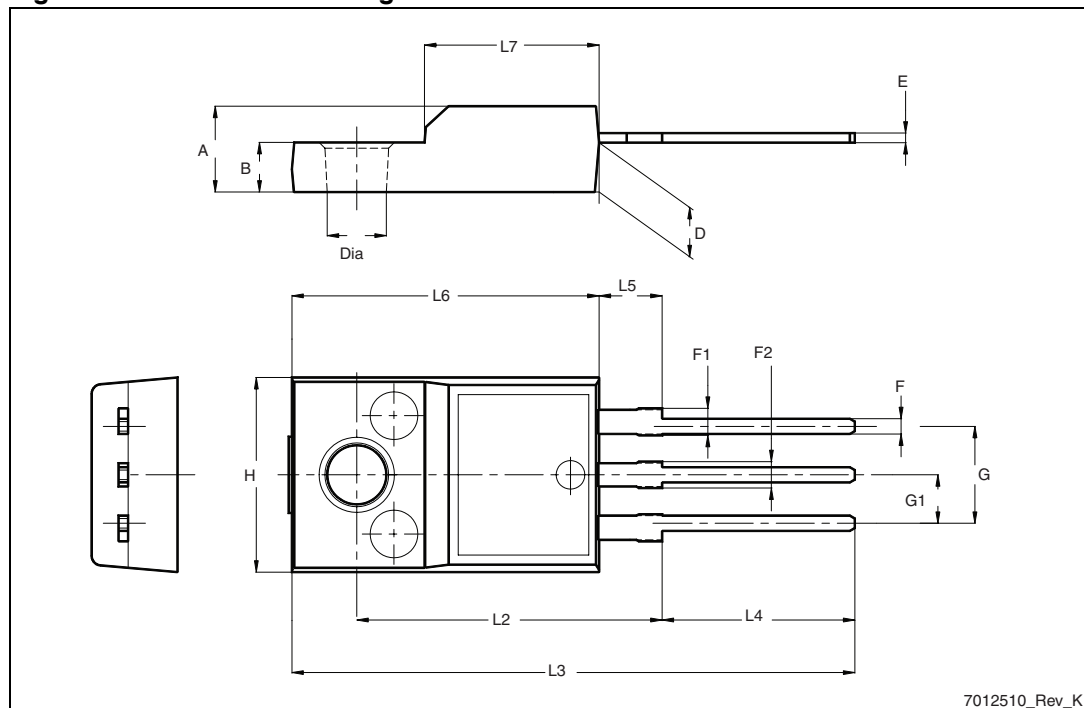
## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

Table 9. TO-220FP mechanical data

| Dim. | mm   |      |      |
|------|------|------|------|
|      | Min. | Typ. | Max. |
| A    | 4.4  |      | 4.6  |
| B    | 2.5  |      | 2.7  |
| D    | 2.5  |      | 2.75 |
| E    | 0.45 |      | 0.7  |
| F    | 0.75 |      | 1    |
| F1   | 1.15 |      | 1.70 |
| F2   | 1.15 |      | 1.70 |
| G    | 4.95 |      | 5.2  |
| G1   | 2.4  |      | 2.7  |
| H    | 10   |      | 10.4 |
| L2   |      | 16   |      |
| L3   | 28.6 |      | 30.6 |
| L4   | 9.8  |      | 10.6 |
| L5   | 2.9  |      | 3.6  |
| L6   | 15.9 |      | 16.4 |
| L7   | 9    |      | 9.3  |
| Dia  | 3    |      | 3.2  |

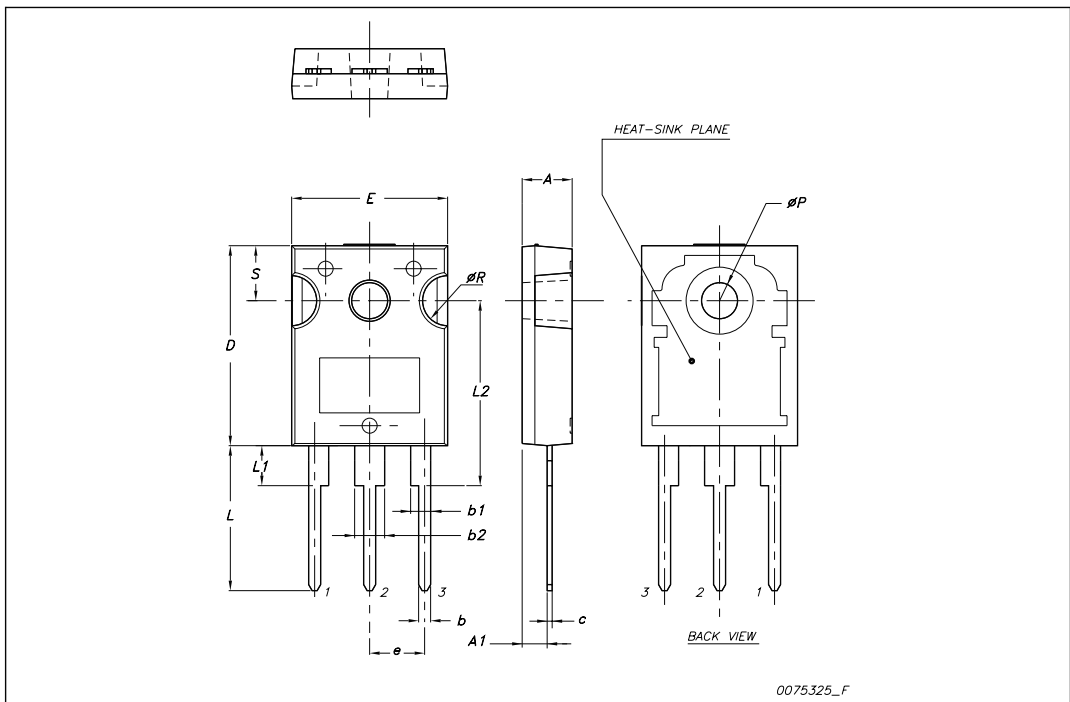
Figure 24. TO-220FP drawing



7012510\_Rev\_K

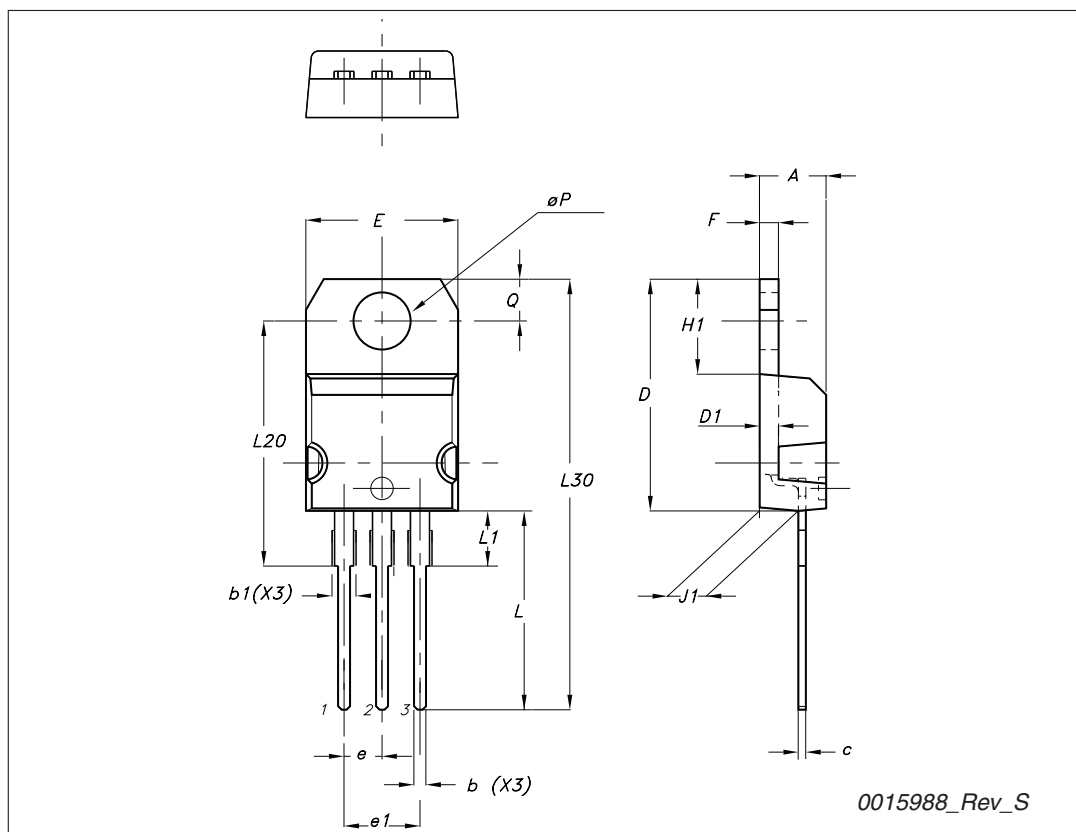
**TO-247 mechanical data**

| Dim. | mm.   |       |       |
|------|-------|-------|-------|
|      | Min.  | Typ.  | Max.  |
| A    | 4.85  |       | 5.15  |
| A1   | 2.20  |       | 2.60  |
| b    | 1.0   |       | 1.40  |
| b1   | 2.0   |       | 2.40  |
| b2   | 3.0   |       | 3.40  |
| c    | 0.40  |       | 0.80  |
| D    | 19.85 |       | 20.15 |
| E    | 15.45 |       | 15.75 |
| e    |       | 5.45  |       |
| L    | 14.20 |       | 14.80 |
| L1   | 3.70  |       | 4.30  |
| L2   |       | 18.50 |       |
| øP   | 3.55  |       | 3.65  |
| øR   | 4.50  |       | 5.50  |
| S    |       | 5.50  |       |



## TO-220 type A mechanical data

| Dim | mm    |       |       |
|-----|-------|-------|-------|
|     | Min   | Typ   | Max   |
| A   | 4.40  |       | 4.60  |
| b   | 0.61  |       | 0.88  |
| b1  | 1.14  |       | 1.70  |
| c   | 0.48  |       | 0.70  |
| D   | 15.25 |       | 15.75 |
| D1  |       | 1.27  |       |
| E   | 10    |       | 10.40 |
| e   | 2.40  |       | 2.70  |
| e1  | 4.95  |       | 5.15  |
| F   | 1.23  |       | 1.32  |
| H1  | 6.20  |       | 6.60  |
| J1  | 2.40  |       | 2.72  |
| L   | 13    |       | 14    |
| L1  | 3.50  |       | 3.93  |
| L20 |       | 16.40 |       |
| L30 |       | 28.90 |       |
| ∅P  | 3.75  |       | 3.85  |
| Q   | 2.65  |       | 2.95  |



## 5 Revision history

Table 10. Document revision history

| Date        | Revision | Changes       |
|-------------|----------|---------------|
| 09-Feb-2010 | 1        | First release |

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